

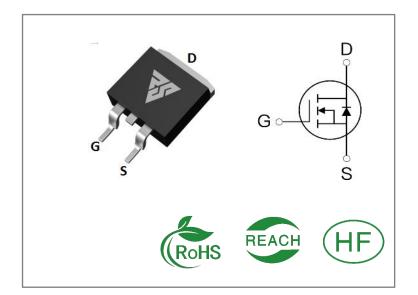
| ID   | R <sub>DS</sub> (ON)(Typ) | VDSS |
|------|---------------------------|------|
| 180A | $2.0 m\Omega$             | 30V  |

## **Applications:**

- Load Switch
- PWM Applications
- Power Managment

#### **Features:**

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



**Ordering Information** 

| Part Number | Package | Marking   | Packing   | Qty.    |
|-------------|---------|-----------|-----------|---------|
| RS30N180S   | T0-263  | RS30N180S | Tape&reel | 800 PCS |

### Absolute Maximun Ratings Tc= 25°C unless otherwise specified

| Symbol         | Parameter   | RS30N180S  | Units      |
|----------------|---|------------|------------|
| VDSS           | Drain-to-Source Voltage   | 30         | V          |
| ID             | Continuous Drain Current TC=25℃   | 180        |            |
| ID             | Continuous Drain Current TC=100℃  | 114        | А          |
| IDM            | Pulsed Drain Current  | 720        |            |
| PD             | Power Dissipation   | 88         | W          |
| VGS            | Gate- to- Source Voltage  | ±20        | V          |
| EAS            | Single Pulse Avalanche Engergy L = 0.5mH,VDD = 15V, RG = $25\Omega$ , Tj = $25^{\circ}$ C | 305        | mJ         |
|                | Maximum Temperature for Soldering   |            |            |
| TL TPKG        | Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds               | 300<br>260 | $^{\circ}$ |
| TJ and<br>TSTG | Operating Junction and Storage<br>Temperature Range                                       | -55 to 150 |            |

<sup>\*</sup> Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



## **Thermal Resistance**

| Symbol | Parameter               | RS30N180S | Units | Test Conditions  |
|--------|-------------------------|-----------|-------|--|
| RθJC   | Junction-to-Case        | 1.3       | °C/W  | Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}{\rm C}$ |
| RθJA   | Junction-to-<br>Ambient | 27        |       | 1 cubic foot chamber,free air.   |

## **OFF Characteristics** TJ= 25 <sup>o</sup>C unless otherwise specified

| Symbol | Parameter                              | Min. | Тур. | Max. | Units | Test Conditions    |
|--------|--|------|------|------|-------|--------------------|
| BVDSS  | Drain- to- source Breakdown<br>Voltage | 30   |      |      | V     | VGS=0V<br>ID=250μA |
| IDSS   | Drain- to- Source Leakage<br>Current   |      |      | 1    | μΑ    | VDS=30V<br>VGS=0V  |
| ICCC   | Gate- to- Source Forward<br>Leakage    |      |      | 100  | - Λ   | VGS=20V<br>VDS=0V  |
| IGSS   | Gate- to- Source Reverse<br>Leakage    |      |      | -100 | nA    | VGS=-20V<br>VDS=0V |

## ON Characteristics TJ=25°C unless otherwise specified

| Symbol   | Parameter   | Min.                   | Тур. | Max. | Units | Test Conditions |
|----------|---|------------------------|------|------|-------|-----------------|
|          |   |                        | 2.0  | 2.5  | mΩ    | VGS=10V         |
| DDS(on)  | RDS(on) Static Drain- to- Source On-Resistance  /GS(TH Gate Threshold Voltage |                        |      |      |       | ID=30A          |
| KD3(011) |   |                        | 3.3  | 4.3  | mΩ    | VGS=4.5V        |
|          |   |                        |      |      |       | ID=20A          |
| VGS(TH   |   | Cata Thurshald Valtage |      | 1 9  | 2.5   | \/              |
| )        | Gate Tiffeshold Voltage   | 1.3                    | 1.9  | 2.5  | V     | ID=250μA        |

## Resistive Switching Characteristics Essentially independent of operating temperature

| Symbol  | Parameter            | Min. | Тур. | Max. | Units | Test Conditions   |
|---------|----------------------|------|------|------|-------|-------------------|
| td(ON)  | Turn- on Delay Time  |      | 16   |      |       | ) (DC 45) /       |
| trise   | Rise Time            |      | 30   |      |       | VDS=15V<br>ID=30A |
| td(OFF) | Turn- OFF Delay Time |      | 52   |      | nS    | RG=3Ω<br>VGS=10V  |
| tfall   | Fall Time            |      | 20   |      |       | vG3=10V           |

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**Dynamic Characteristics** Essentially independent of operating temperature

| Symbol | Parameter                       | Min. | Тур. | Max. | Units | Test Conditions |
|--------|---------------------------------|------|------|------|-------|-----------------|
| Ciss   | Input Capacitance               |      | 5060 |      |       | VGS= 0V         |
| Coss   | Output Capacitance              |      | 570  |      | рF    | VDS=15V         |
| Crss   | Reverse Transfer Capacitance    |      | 470  |      |       | f=1.0MHz        |
| Qg     | Total Gate Charge               |      | 75   |      |       | VDS= 15V        |
| Qgs    | Gate- to- Source Charge         |      | 9    |      | nC    | ID=20A          |
| Qgd    | Gate-to-Drain(" Miller") Charge |      | 18   |      |       | VGS=10V         |

#### **Source-Drain Diode Characteristics**

| Symbol | Parameter                 | Min. | Тур. | Max. | Units | Test Conditions         |
|--------|---------------------------|------|------|------|-------|-------------------------|
| IS     | Continuous Source Current |      |      | 180  | Α     | Integral pn- diode      |
| ISM    | Maximum Pulsed Current    |      |      | 720  | Α     | in MOSFET               |
| VSD    | Diode Forward Voltage     |      |      | 1.2  | V     | IS=30A,VGS=0V           |
| trr    | Reverse Recovery Time     |      | 24   |      | nS    | VGS=0V                  |
| Qrr    | Reverse Recovery Charge   |      | 14   |      | nC    | IS=30A<br>di/dt=100A/μs |

#### Notes:

<sup>\* 1.</sup> Repetitive rating, pulse width limited by maximum junction temperature.

<sup>\* 2.</sup> Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 0.5%



#### **Typical Feature Curve**

Figure 1: Output Characteristics

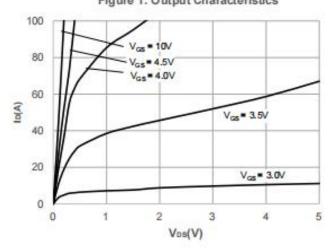


Figure 2: Typical Transfer Characteristics

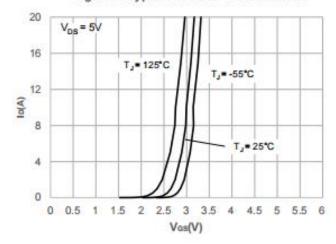


Figure 3: On-resistance vs. Drain Current

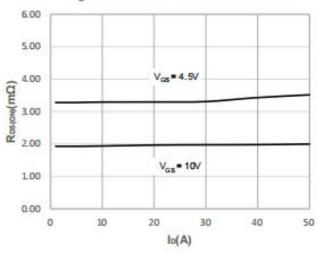


Figure 4: Body Diode Characteristics

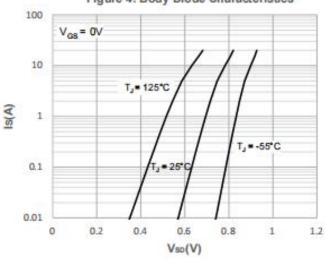


Figure 5: Gate Charge Characteristics

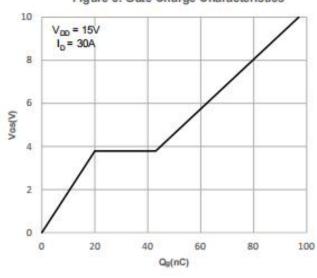
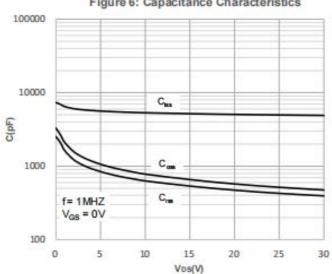


Figure 6: Capacitance Characteristics



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Figure 7: Normalized Breakdown voltage vs. Junction Temperature

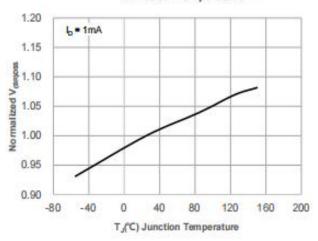


Figure 8: Normalized on Resistance vs. Junction Temperature

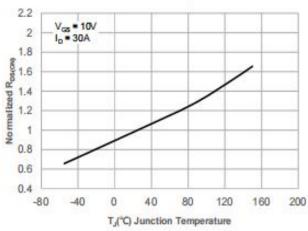


Figure 9: Maximum Safe Operating Area

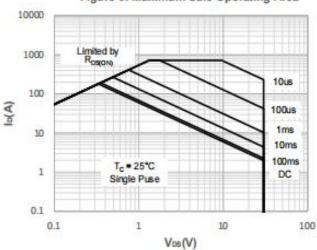


Figure 10: Maximum Continuous Drian Current vs. Case Temperature

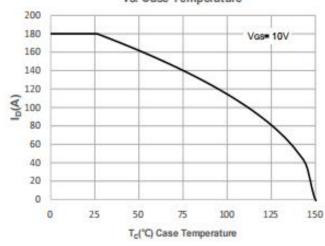


Figure 11: Normalized Maximum Transient Thermal Impedance

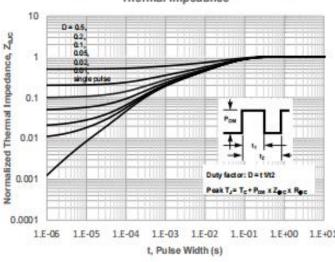
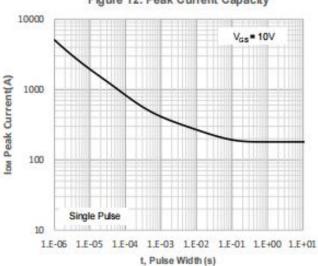


Figure 12: Peak Current Capacity



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#### **Test ircuits and Waveforms**

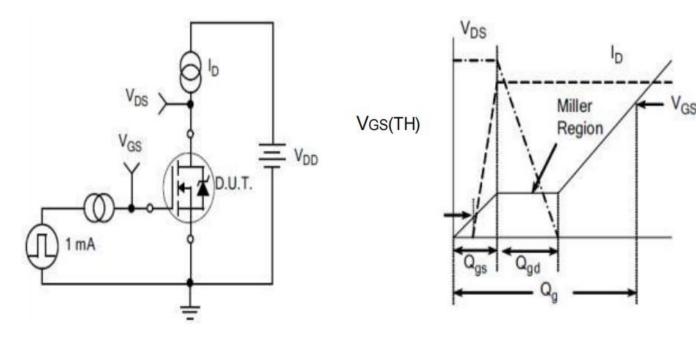


Figure A.
Gate Charge Test Circuit

Figure B.
Gate Charge Waveform

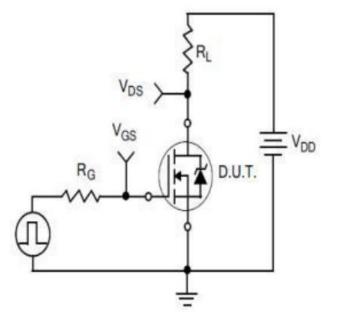


Figure C.
Resistive Switching Test Circuit

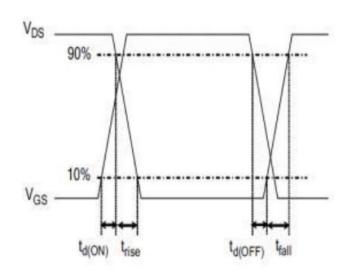
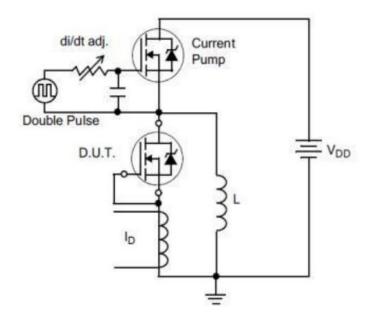


Figure D.
Resistive Switching Waveforms



#### **Test ircuits and Waveforms**



 $\frac{di/dt = 100A/\mu A}{Q_{rr}}$ 

Figure E.Diode Reverse Recovery Test Circuit

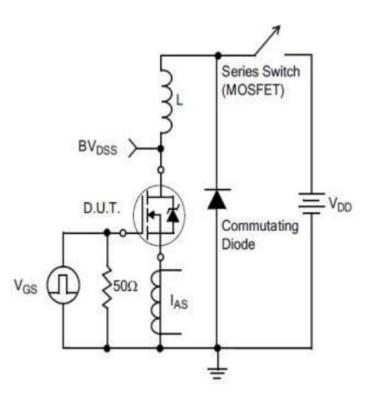


Figure F.Diode Reverse Recovery Waveform

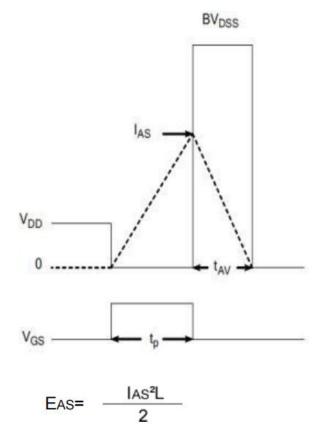
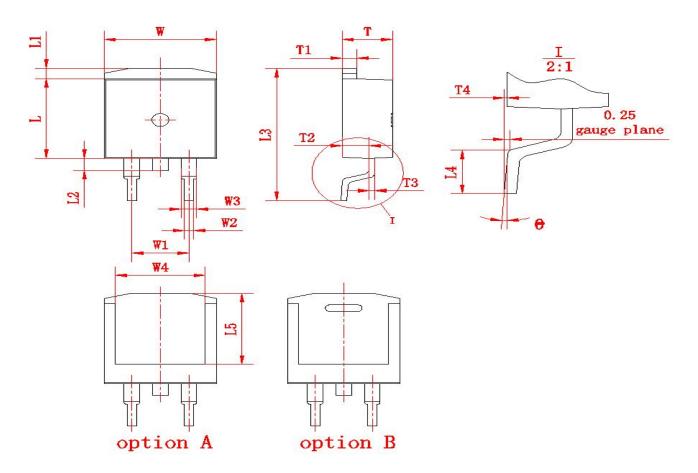


Figure G.Unclamped Inductive Switching Test Circuit

Figure H.Unclamped Inductive Switching Waveforms



# Package outline drawing(TO-263 Unit: mm)



(单位: mm)

| 符号         | 尺寸    |        | かロ | 尺寸     |        | 75 D | 尺寸    |       |
|------------|-------|--------|----|--------|--------|------|-------|-------|
|            | Min   | Max    | 符号 | Min    | Max    | 符号   | Min   | Max   |
| W          | 9.80  | 10. 20 | L1 | 1.00   | 1.40   | T1   | 1. 20 | 1.40  |
| W1         | (5.   | 08)    | L2 | 1. 20  | 1.60   | T2   | 2. 20 | 2. 60 |
| W2         | 0. 70 | 0. 95  | L3 | 15. 00 | 15. 60 | Т3   | 0. 45 | 0.65  |
| <b>W</b> 3 | 1. 17 | 1. 62  | L4 | 2. 20  | 2.80   | T4   | 0     | 0. 25 |
| W4         | (8    | . 0)   | L5 | (8. 2) |        | θ    | 0°    | 8°    |
| L          | 9.00  | 9. 40  | T  | 4. 30  | 4. 70  |      |       |       |



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